



SEMiX® 5

Trench IGBT Modules

SEMiX205GD12E4V2

Features*

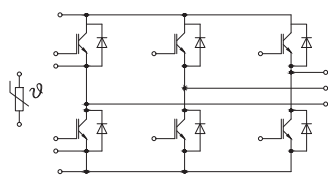
- Solderless assembly solution with PressFIT signal pins and screw power terminals
- IGBT 4 Trench Gate Technology
- $V_{CE(sat)}$ with positive temperature coefficient
- Low inductance case
- Reliable mechanical design with injection moulded terminals and robust internal connections
- UL recognized file no. E63532
- NTC temperature sensor inside

Typical Applications

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125^{\circ}\text{C}$ max.
- Product reliability results are valid for $T_{jop}=150^{\circ}\text{C}$
- Please refer to Semix5p Technical Explanations for mounting conditions



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Absolute Maximum Ratings

Symbol	Conditions		Values	Unit
IGBT				
V _{CES}	T _j = 25 °C		1200	V
I _C	T _j = 175 °C	T _c = 25 °C	313	A
		T _c = 80 °C	239	A
I _{Cnom}			200	A
I _{CRM}			600	A
V _{GES}			-20 ... 20	V
t _{psc}	V _{CC} = 800 V V _{GE} ≤ 15 V V _{CES} ≤ 1200 V	T _j = 150 °C	10	μs
T _j			-40 ... 175	°C
Inverse diode				
V _{RRM}	T _j = 25 °C		1200	V
I _F	T _j = 175 °C	T _c = 25 °C	224	A
		T _c = 80 °C	167	A
I _{FRM}			400	A
I _{FSM}	t _p = 10 ms, sin 180°, T _j = 25 °C		990	A
T _j			-40 ... 175	°C
Module				
I _{t(RMS)}			300	A
T _{stg}	module without TIM		-40 ... 125	°C
V _{isol}	AC sinus 50Hz, t = 1 min		4000	V

Characteristics

Symbol	Conditions	min.	typ.	max.	Unit
IGBT					
$V_{CE(sat)}$	$I_C = 200\text{ A}$ $V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^{\circ}\text{C}$	1.80	2.05	V
		$T_j = 150^{\circ}\text{C}$	2.05	2.30	V
V_{CE0}	chipelevel	$T_j = 25^{\circ}\text{C}$	0.87	1.01	V
		$T_j = 150^{\circ}\text{C}$	0.77	0.90	V
r_{CE}	$V_{GE} = 15\text{ V}$ chipelevel	$T_j = 25^{\circ}\text{C}$	4.7	5.2	$\text{m}\Omega$
		$T_j = 150^{\circ}\text{C}$	6.4	7.0	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE} = V_{CE}, I_C = 7.4\text{ mA}$	5.1	5.8	6.3	V
I_{CES}	$V_{GE} = 0\text{ V}, V_{CE} = 1200\text{ V}, T_j = 25^{\circ}\text{C}$			2.6	mA
C_{ies}	$V_{CE} = 25\text{ V}$ $V_{GE} = 0\text{ V}$	$f = 1\text{ MHz}$	12.5		nF
C_{oes}		$f = 1\text{ MHz}$	-		nF
C_{res}		$f = 1\text{ MHz}$	0.68		nF
Q_G	$V_{GE} = -15\text{ V} \dots +15\text{ V}$		2087		nC
R_{Gint}	$T_j = 25^{\circ}\text{C}$		3.5		Ω
$t_{d(on)}$	$V_{CC} = 600\text{ V}$	$T_j = 150^{\circ}\text{C}$	145		ns
t_r	$I_C = 200\text{ A}$	$T_j = 150^{\circ}\text{C}$	43		ns
E_{on}	$V_{GE} = +15/-15\text{ V}$ $R_{G on} = 1\text{ }\Omega$	$T_j = 150^{\circ}\text{C}$	14		mJ
$t_{d(off)}$	$R_{G off} = 1\text{ }\Omega$	$T_j = 150^{\circ}\text{C}$	457		ns
t_f	$di/dt_{on} = 4500\text{ A}/\mu\text{s}$ $di/dt_{off} = 1353\text{ A}/\mu\text{s}$	$T_j = 150^{\circ}\text{C}$	82		ns
E_{off}		$T_j = 150^{\circ}\text{C}$	22.8		mJ
$R_{th(j-c)}$	per IGBT			0.15	K/W
$R_{th(c-s)}$	per IGBT ($\lambda_{grease}=0.81\text{ W/mK}$, thickness 50-100 μm)		0.055		K/W
$R_{th(c-s)}$	per IGBT ($\lambda=3.4\text{ W/mK}$)		t.b.d.		K/W



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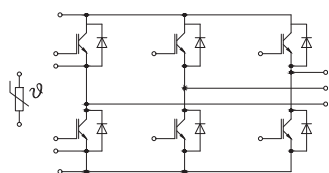
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Characteristics						
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Inverse diode						
V _F = V _{EC}	I _F = 200 A	T _j = 25 °C		2.20	2.52	V
	V _{GE} = 0 V chiplevel	T _j = 150 °C		2.15	2.47	V
V _{F0}	chiplevel	T _j = 25 °C		1.30	1.50	V
		T _j = 150 °C		0.90	1.10	V
r _F	chiplevel	T _j = 25 °C		4.5	5.1	mΩ
		T _j = 150 °C		6.3	6.9	mΩ
I _{RRM}	I _F = 200 A	T _j = 150 °C		250		A
Q _{rr}	di/dt _{off} = 4500 A/μs	T _j = 150 °C		37		μC
E _{rr}	V _{GE} = -15 V	T _j = 150 °C		16		mJ
	V _{CC} = 600 V					
R _{th(j-c)}	per diode				0.27	K/W
R _{th(c-s)}	per diode (λ _{grease} =0.81 W/mK, thickness 50-100μm)			0.065		K/W
R _{th(c-s)}	per diode (λ=3.4 W/mK)			t.b.d.		K/W
Module						
L _{CE}				20		nH
R _{CC'+EE'}	measured per switch	T _C = 25 °C		1.2		mΩ
		T _C = 125 °C		1.65		mΩ
R _{th(c-s)1}	calculated without thermal coupling			0.005		K/W
R _{th(c-s)2}	including thermal coupling, T _s underneath module (λ _{grease} =0.81 W/(m²K))			0.0081		K/W
R _{th(c-s)2}	including thermal coupling, T _s underneath module, pre-applied phase change material			t.b.d.		K/W
M _s	to heat sink (M5)		3		6	Nm
M _t		to terminals (M6)	3		6	Nm
						Nm
w				398		g
Temperature Sensor						
R ₁₀₀	T _C =100°C (R ₂₅ =5 kΩ)			493 ± 5%		Ω
B _{100/125}	R _(T) =R ₁₀₀ exp[B _{100/125} (1/T-1/T ₁₀₀)]; T[K];			3550 ±2%		K



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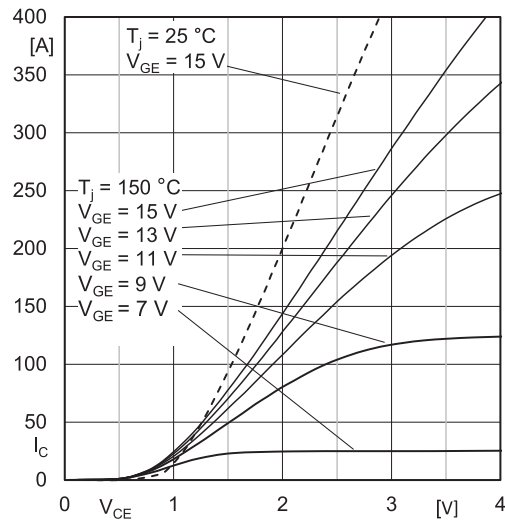


Fig. 1: Typ. output characteristic, inclusive $R_{CC'} + E_{E'}$

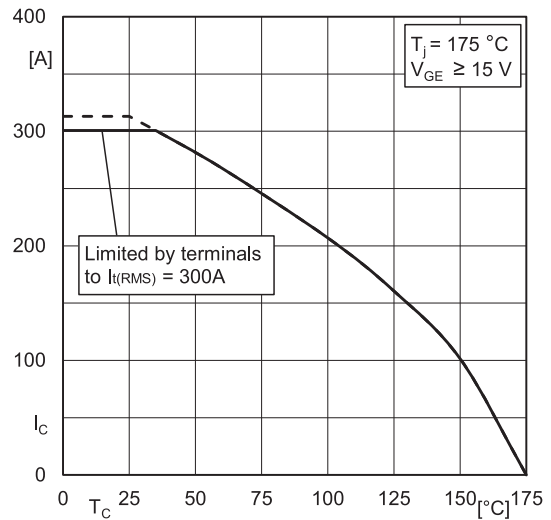


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

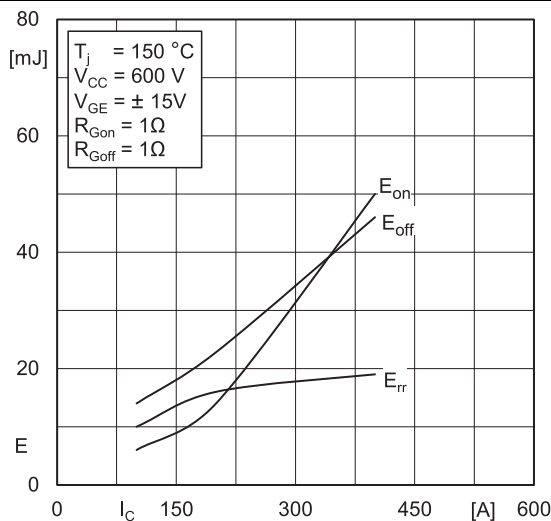


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

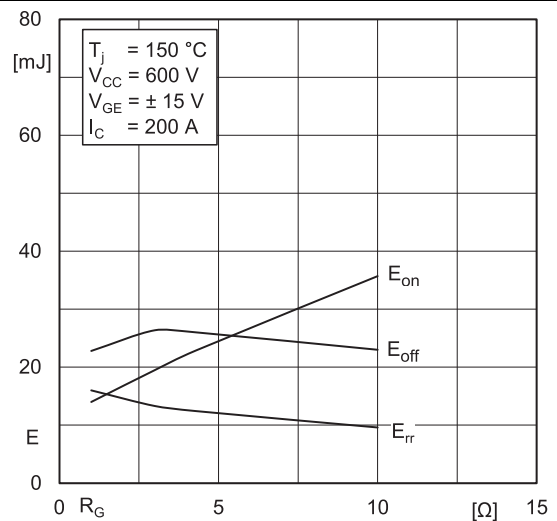


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

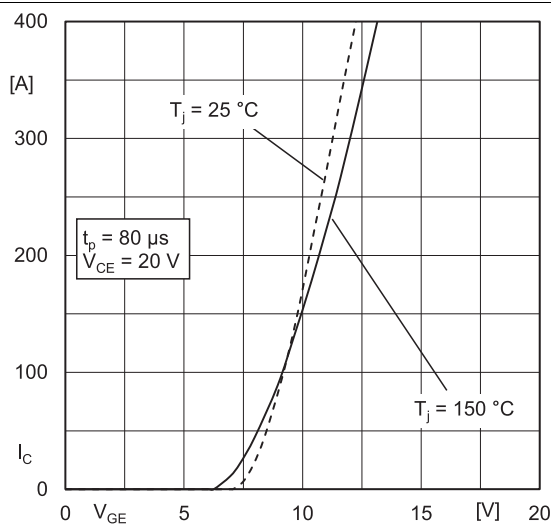


Fig. 5: Typ. transfer characteristic

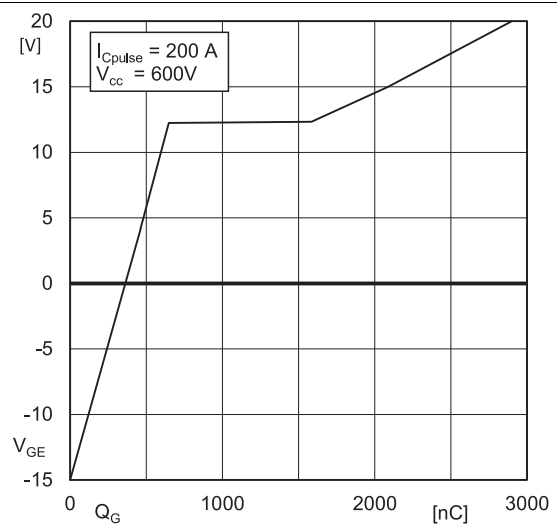


Fig. 6: Typ. gate charge characteristic

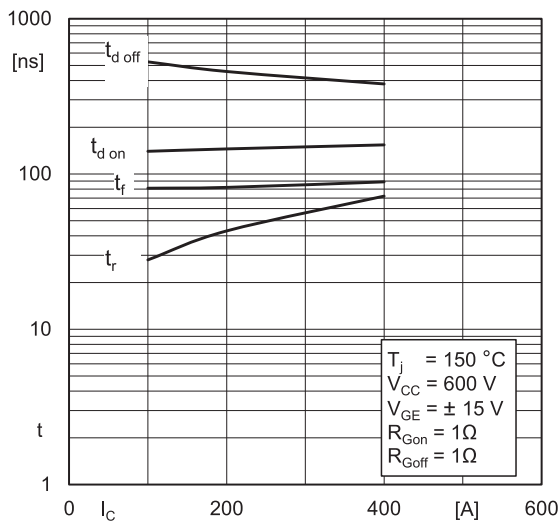


Fig. 7: Typ. switching times vs. I_C

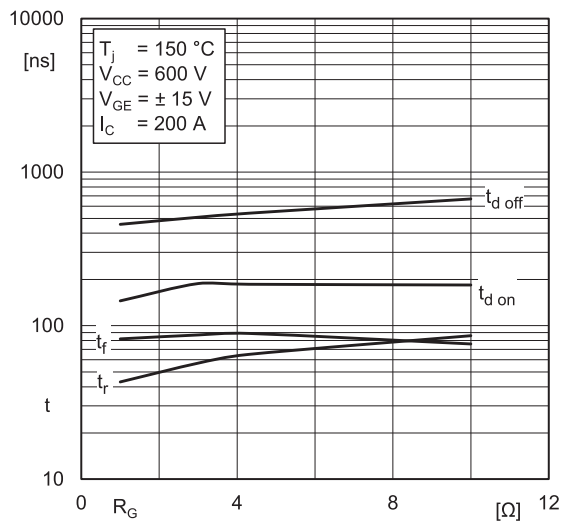


Fig. 8: Typ. switching times vs. gate resistor R_G

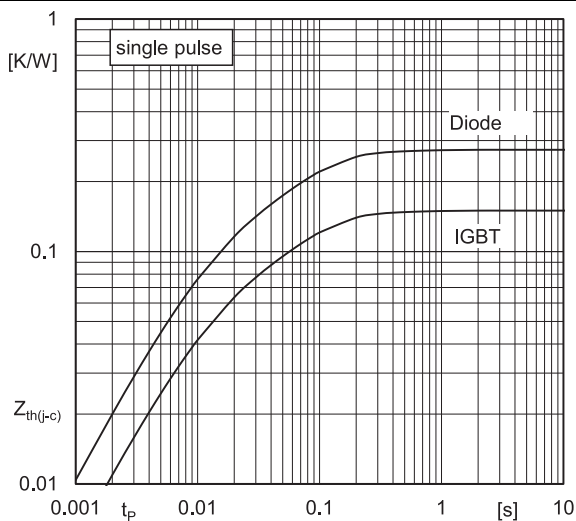


Fig. 9: Typ. transient thermal impedance

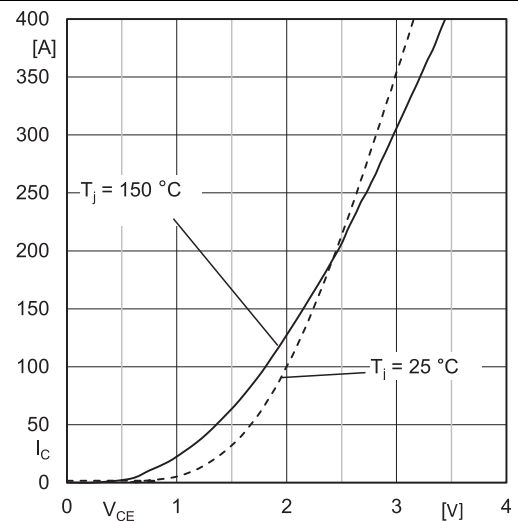


Fig. 10: Typ. CAL diode forward charact., incl. $R_{CC'}+EE'$

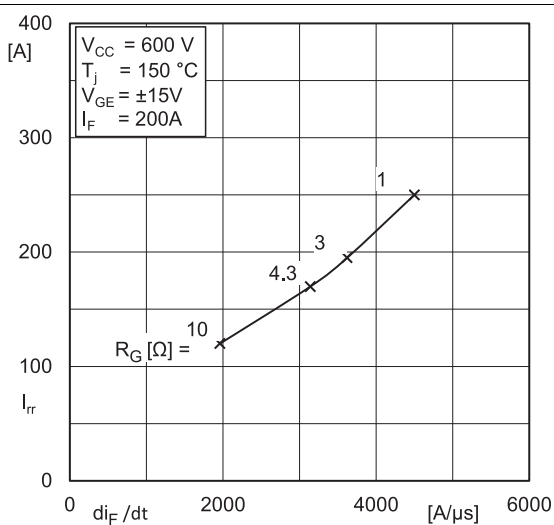
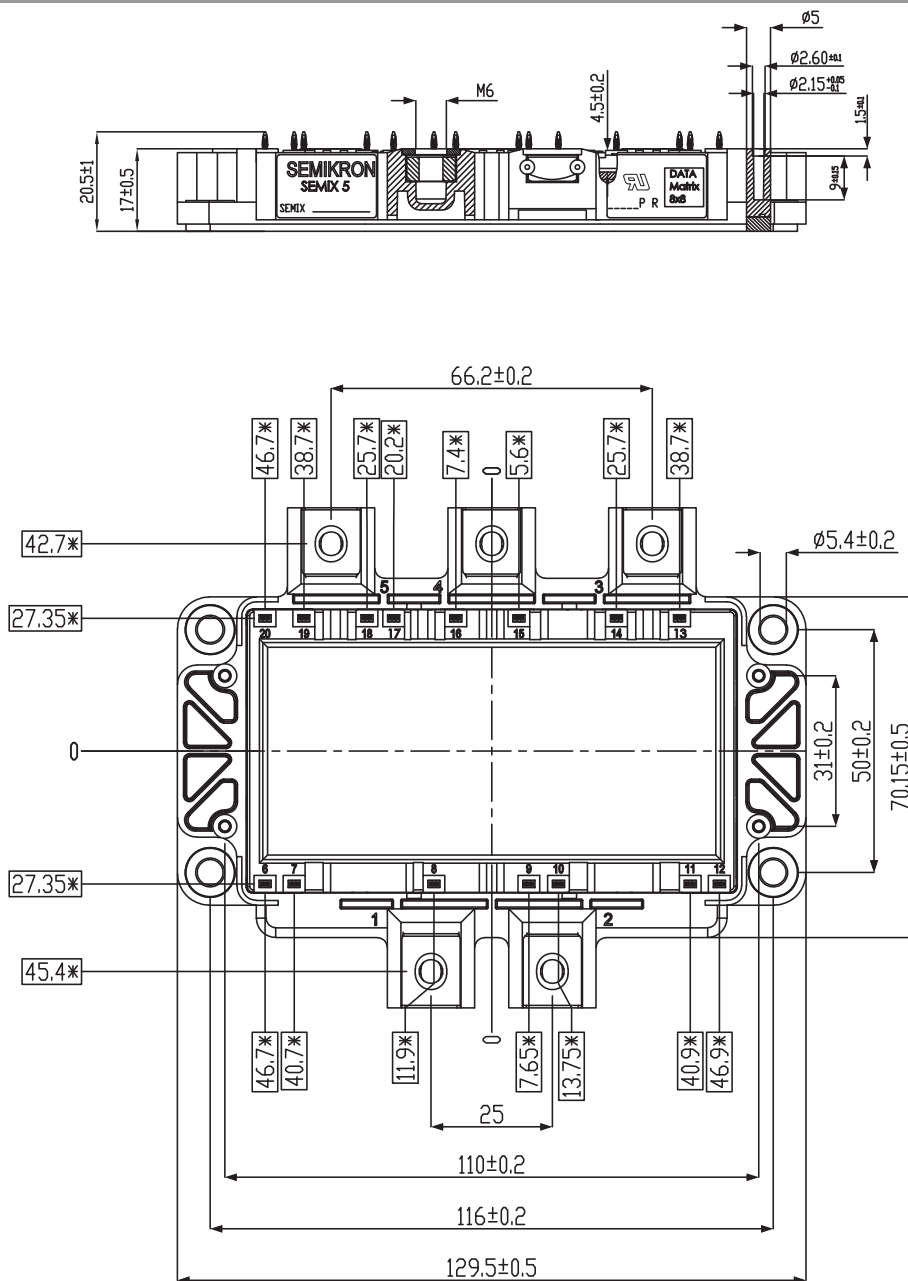


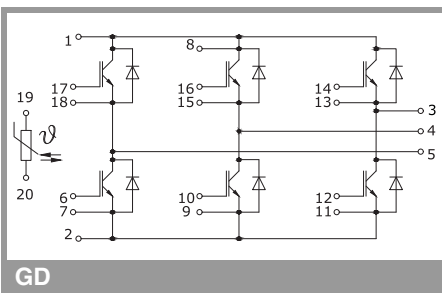
Fig. 11: Typ. CAL diode peak reverse recovery current



* = Dimensions in mm with tolerance of ± 0.4

For technical details please refer
to SEMiX(R)5 Mounting Instruction

SEMIX5p



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This is an electrostatic discharge sensitive device (ESDS) due to international standard IEC 61340.

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